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| Notice of References Cited | Application/Control No. 09/888,773 | Applicant(s)/Patent Under Reexamination MCALPINE ET AL. | |
| | Examiner Hae M Hyeon | Art Unit 2839 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-4,725,453 | 02-1988 | Nakasone et al. | 427/163.2 |
| | B | US-5,165,003 | 11-1992 | Carter, Thomas L. | 385/112 |
| | C | US-5,184,381 | 02-1993 | Coons et al. | 28/271 |
| | D | US-5,268,971 | 12-1993 | Nilsson et al. | 385/101 |
| | E | US-6,088,499 | 07-2000 | Newton et al. | 385/112 |
| | F | US-6,321,012 | 11-2001 | Shen, Steven Xuefeng | 385/106 |
| | G | US-6,482,512 | 11-2002 | Schwartz, Nathan G. | 428/364 |
| | H | US-6,574,400 | 06-2003 | Lail, Jason C. | 385/109 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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